Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/987,118	NOMURA ET AL.	
Examiner	Art Unit	
Thuy N. Pardo	2165	

SEARCHED						
Class	Subclass	Date	Examiner			
707	101	6/25/06	7P 			
	102					
	1032					
	104.1					
705	10					
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702	185	V	$-\sqrt{}$			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
767	101	6/23/06	TP		
	102	/			
	103≥				
<del></del>	104.1				
705	10				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST IEEE	6/23/06	TP		